

**Notice of References Cited**

Application/Control No.

09/346,678

Applicant(s)/Patent Under  
Reexamination  
IWANE ET AL.

Examiner

José R. Díaz

Art Unit

2815

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**U.S. PATENT DOCUMENTS**

*		Document Number	Date	Name	Classification	
		Country Code-Number-Kind Code	MM-YYYY			
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	B	US-6,087,681-A	07-2000	Shakuda	257	103
	C	US- -				
	D	US- -				
	E	US- -				
	F	US- -				
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	I	US- -				
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	K	US- -				
	L	US- -				
	M	US- -				

**FOREIGN PATENT DOCUMENTS**

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		Country Code-Number-Kind Code	MM-YYYY				
	N	- -					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages					
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